

WHAT IS CLAIMED IS

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1. A method of forming a metal film from a metal carbonyl compound source, comprising the steps of:

(A) introducing a gaseous source material
10 containing a metal carbonyl compound into a process space adjacent to a surface of a substrate to be processed in such a manner that said metal carbonyl compound has a first partial pressure;

(B) depositing a metal film on said surface
15 of said substrate by introducing a gaseous source material containing said metal carbonyl compound into said process space in such a manner that said metal carbonyl compound has a second, smaller partial pressure,

20 said step (A) being conducted such that there is caused no substantial deposition of said metal film on said substrate.

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2. A method as claimed in claim 1, wherein said step (A) is conducted by setting the temperature of a source vessel holding said metal carbonyl
30 compound to a first temperature, and wherein said step (B) is conducted by setting the temperature of a source vessel holding said metal carbonyl compound to a second, lower temperature.

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3. A method as claimed in claim 1, wherein
said step (A) is conducted by setting a flow rate of
a carrier gas to a first value when supplying said
gaseous source material containing said metal
5 carbonyl compound to said process space and wherein
said step (B) is conducted by setting said flow rate
of said carrier gas to a second, larger value.

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4. A method as claimed in claim 1, wherein
said step (A) is conducted by supplying said gaseous
source material containing said metal carbonyl
15 compound into said process space while setting a
pressure of said process space to a first pressure,
and wherein said step (B) is conducted by supplying
said gaseous source material containing said metal
carbonyl compound into said process space while
20 setting a pressure of said process space to a second,
lower pressure.

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5. A method as claim 4, wherein said first
pressure is about 70Pa or less.

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6. A method as claimed in claim 4, wherein
said second pressure is about 13Pa or less.

7. A method as claimed in claim 1, wherein said step (A) and said step (B) are conducted at a substrate temperature of less than 500°C.

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8. A method as claimed in claim 1, wherein said step (A) and said step (B) are conducted at a
10 substrate temperature of less than 400°C.

15 9. A method as claimed in claim 1, wherein a surface of said substrate is covered with an insulation film.

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10. A method as claimed in claim 1, wherein said metal carbonyl compound is selected from the group consisting of $W(CO)_6$, $Co(CO)_6$, $Mo(CO)_6$ and
25 $[Rh(CO)_4]_4$.

30 11. A method as claimed in claim 1, wherein said steps (A) and (B) are conducted continuously in a common processing vessel.